

| | | | | |
|-----------------------------------|--|---------------------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. 09/874,104 | Applicant(s)/Patent Under Reexamination HAINES ET AL. | |
| | | Examiner Kristie Shingles | Art Unit 2141 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-2002/0133540 | 09-2002 | Sears et al. | 709/203 |
| * | B | US-6,076,108 | 06-2000 | Courts et al. | 709/227 |
| * | C | US-2002/0007317 | 01-2002 | CALLAGHAN et al. | 705/26 |
| * | D | US-6,529,952 | 03-2003 | Blumenau, Trevor | 709/223 |
| * | E | US-5,774,670 | 06-1998 | Montulli, Lou | 709/227 |
| * | F | US-2002/0078192 | 06-2002 | Kopsell et al. | 709/223 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.